

PATENT APPLICATION

Sheet 1 of 1

FORM PTO-1449 LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)	ATTY. DOCKET NO. 200300296-1	APPLICATION NO.	CONFIRMATION NO.
	APPLICANT Cheolmin PARK et al.		
	FILING DATE Her with	GROUP	

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION DATE	NAME	Pages, Columns, Lines Where Relevant Passages or Figures Appear
	1A				
	1B				
	1C				
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	1I				
	1J				
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	Pages/Columns/Lines Where Relevant Passages/Figures Appear	Check if Translation attached
	1L					
	1M					
	1N					
	1O					
	1P					

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

mw	1Q	Ernest Y. Wu et al.; "Experimental Evidence of TBD Power-Law for Voltage Dependence of Oxide Breakdown in Ultrathin Gate Oxides"; IEEE Transactions on Electron Devices, Vol. 40, No. 12, December 2002 (pp. 2244-2253).
	1R	
	1S	

EXAMINER

Megan S Walling

DATE CONSIDERED

5/9/05